

CLC2011, CLC4011

Low Power, Low Cost, Rail-to-Rail I/O Amplifiers

General Description

The CLC2011 (dual) and CLC4011 (quad) are ultra-low cost, low power, voltage feedback amplifiers. At 2.7V, the CLCx011 family uses only 136µA of supply current per amplifier and are designed to operate from a supply range of 2.5V to 5.5V (±1.25 to ±2.75). The input voltage range exceeds the negative and positive rails.

The CLCx011 family of amplifiers offer high bipolar performance at a low CMOS prices. They offer superior dynamic performance with 4.9MHz small signal bandwidths and 5.3V/µs slew rates. The combination of low power, high bandwidth, and rail-to-rail performance make the CLCx011 amplifiers

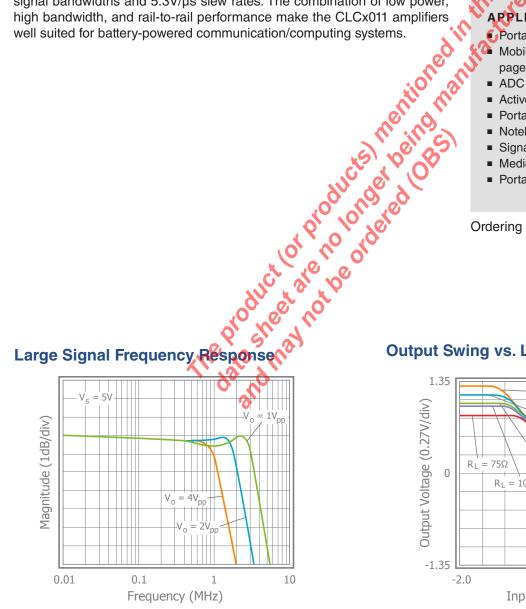
FEATURES

- 136µA supply current
- 4.9MHz bandwidth
- Output swings to within 20mV of either rail
- Input voltage range exceeds the rail by >250mV
- 5.3V/µs slew rate
- 21nV/√Hz input voltage noise
- ±35mA linear output current
- Fully specified at 2.7V and 5V supplies

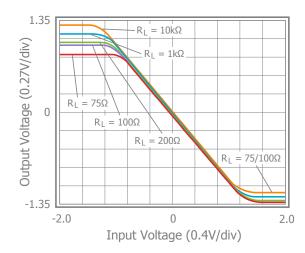
APPLICATIONS

- Portable/battery-powered applications
- Mobile communications, cell phones, pagers
- ADC buffer
- Active filters
- Portable test instruments
- Notebooks and PDA's
- Signal conditioning
- Medical equipment
- Portable medical instrumentation

Ordering Information - back page



Output Swing vs. Load



Absolute Maximum Ratings

Stresses beyond the limits listed below may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

V _S	0V to 6V
V _{IN}	V_S - 0.5V to + V_S +0.5V
Continuous Output Current	40mA to +40mA

Operating Conditions

Supply Voltage Range	2.5 to 5.5V
Operating Temperature Range	40°C to 125°C
Junction Temperature	150°C
Storage Temperature Range	65°C to 150°C
Lead Temperature (Soldering, 10s)	260°C

Package Thermal Resistance

θ _{JA} (SOIC-8)	150°C/W
θ _{JA} (MSOP-8)	200°C/W
θ _{JA} (SOIC-14)	90°C/W
θ _{JA} (TSSOP-14)	100°C/W
θ_{JA} (TSSOP-14)	standard, multi-layer

ESD Protection
CLC20(1, CLC4011 (HBM)2kV
ESD Rating for HBM (Human Body Model).
CLC201, CLC2011 (HBM)
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Electrical Characteristics at +2.7V

 $T_A=25^{\circ}C,\,V_S=+2.7V,\,R_f=R_g=5k\Omega,\,R_L=10k\Omega\;to\;V_S/2;\,G=2;\,unless\;otherwise\;noted.$

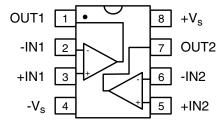
Frequency Domain Response UGBW _{SS} Unity Gain 3dB Bandwidth G = +1, V _{OUT} = 0.02V _{pp} 4.9 MHz BW _{SS} 3dB Bandwidth G = +2, V _{OUT} = 2V _{pp} 1.4 MHz BW _{LS} Large Signal Bandwidth G = +2, V _{OUT} = 2V _{pp} 1.4 MHz GBWP Gain Bandwidth Product G = +11, V _{OUT} = 0.2V _{pp} 2.5 MHz GBWP Gain Bandwidth Product G = +11, V _{OUT} = 0.2V _{pp} 2.5 MHz Implemental Response Time Demain Response WE 163 ns ts Settling Time to 0.1% V _{OUT} = 1V step 500 ns SR Slew Rate 1V step 5.3 V _I ys SR Slew Rate 1V step 5.3 V _I ys DistortionNoise Response 1V step 5.3 V _I ys HD2 2nd Harmonic Distortion 10kHz, V _{OUT} = 1V _{pp} 7-72 dBc HD3 3rd Harmonic Distortion 10kHz, V _{OUT} = 1V _{pp} 0.03 % Fe Input Voltage Noise 10kHz, V _{OUT} = 1V _{pp}	Symbol	Parameter	Conditions	Min	Тур	Max	Units			
BWss -3dB Bandwidth G = +2, V _{OUT} = 0.2V _{pp} 3.2 MHz BWts Large Signal Bandwidth G = +2, V _{OUT} = 2V _{pp} 1.4 MHz BWW Gain Bandwidth Product G = +11, V _{OUT} = 0.2V _{pp} 2.5 MHz Time Domain Response Web Bis and Fall Time V _{OUT} = 1V step; (10% to 90%) 163 ns Is Settling Time to 0.1% V _{OUT} = 1V step 500 ns OS Overshoot V _{OUT} = 1V step 500 ns SR Slew Rate 1V step 5.3 V/µs DistortionNoise Response Web 5.3 V/µs HD2 2nd Harmonic Distortion 10kHz, V _{OUT} = 1V _{pp} -72 dBc HD2 2nd Harmonic Distortion 10kHz, V _{OUT} = 1V _{pp} -72 dBc HD3 3rd Harmonic Distortion 10kHz, V _{OUT} = 1V _{pp} -72 dBc THD Total Harmonic Distortion 10kHz, V _{OUT} = 1V _{pp} -72 dBc THD Total Harmonic Distortion 10kHz, V _{OUT} = 1V _{pp} -72 <td< td=""><td>Frequency</td><td colspan="9">Frequency Domain Response</td></td<>	Frequency	Frequency Domain Response								
BW _S Large Signal Bandwidth G = +2, V _{OUT} = 2V _{pp} 2.5 MHz	UGBW _{SS}	Unity Gain -3dB Bandwidth	$G = +1, V_{OUT} = 0.02V_{pp}$		4.9		MHz			
BW _S Large Signal Bandwidth G = +2, V _{OUT} = 2V _{pp} 2.5 MHz	BW _{SS}	-3dB Bandwidth	$G = +2, V_{OUT} = 0.2V_{pp}$		3.2		MHz			
Gain Bandwidth Product G = +11, V _{OUT} = 0.2V _{pp} 2.5 MHz	BW _{LS}	Large Signal Bandwidth			1.4		MHz			
Inju File File	GBWP	Gain Bandwidth Product			2.5		MHz			
Is Settling Time to 0.1% V _{OUT} = 1V step 500 ns OS Overshoot V _{OUT} = 1V step <1	Time Doma	in Response			,		,			
OS Overshoot Vout = 1V step	t _R , t _F	Rise and Fall Time	V _{OUT} = 1V step; (10% to 90%)		163		ns			
SR Slew Rate 1V step 5.3 V/μs	t _S	Settling Time to 0.1%	V _{OUT} = 1V step		500		ns			
Distortion/Noise Response		Overshoot	V _{OUT} = 1V step		<1		%			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	SR	Slew Rate	1V step	•	5.3		V/µs			
HD3	Distortion/N	loise Response	*14, 140							
HD3	HD2	2nd Harmonic Distortion	10kHz, V _{OUT} = 1V _{pp}		-72		dBc			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	HD3	3rd Harmonic Distortion			-72		dBc			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	THD	Total Harmonic Distortion			0.03		%			
Channel to Channel Vout 2Vpp, f = 50kHz	e _n	Input Voltage Noise	>10kHz		21		nV/√Hz			
Channel to Channel Vout 2Vpp, f = 50kHz			Channel to Channel, Vout = 2Vpp, f = 10kHz		82		dB			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	X _{TALK}	Crosstalk			74		dB			
	DC Perform	ance	W. W.		,		,			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	V _{IO}	Input Offset Voltage	6,00,00		0.5		mV			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	d _{VIO}	Average Drift	(2,100)		5		μV/°C			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	I _B	Input Bias Current	111 40, 1		90		nA			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	dl _B	Average Drift	0,40,60		32		pA/°C			
$\begin{tabular}{ c c c c c c c c c c } \hline I_S & Supply Current & per channel & 136 & μA \\ \hline Input Characteristics & & & & & & \\ \hline R_{IN} & Input Resistance & Monsinverting & 12 & $M\Omega$ \\ \hline C_{IN} & Input Capacitance & 2 & pF \\ \hline CMIR & Common Mode Input Range & & & & & & \\ \hline CMRR & Common Mode Rejection Ratio & DC & 81 & dB \\ \hline Output Characteristics & & & & & & \\ \hline V_{OUT} & Output Voltage Swing & & & & & & \\ \hline R_L = 10k\Omega \ to \ V_S/2 & & & & & & \\ \hline R_L = 10k\Omega \ to \ V_S/2 & & & & & & \\ \hline R_L = 200\Omega \ to \ V_S/2 & & & & & & \\ \hline R_L = 200\Omega \ to \ V_S/2 & & & & & \\ \hline \end{array}$	PSRR	Power Supply Rejection Ratio	DC	55	83		dB			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	A _{OL}	Open Loop Gain	Vout = Vs / 2		90		dB			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	I _S	Supply Current			136		μA			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Chara	acteristics	1000		,		,			
CMIR Common Mode Input Range	R _{IN}	Input Resistance	Non-inverting		12		ΜΩ			
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	C _{IN}	Input Capacitance	70		2		pF			
$V_{OUT} \begin{array}{ c c c c c }\hline Output \ Characteristics & & & & & & & & & & & & & & & & & & &$	CMIR	Common Mode Input Range	9				V			
$V_{OUT} \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	CMRR	Common Mode Rejection Ratio	DC		81		dB			
$V_{OUT} \qquad \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Output Cha	racteristics								
Vout Votage Swing $R_L = 16Ω \text{ to V}_S / 2$ 2.63 V $R_L = 200Ω \text{ to V}_S / 2$ 0.11 to 2.52 V		and	$R_L = 10k\Omega$ to $V_S / 2$				V			
$n_L = 200\Omega \ 10 \ V_S / 2$ 2.52	V_{OUT}	Output Voltage Swing	$R_L = 1k\Omega$ to $V_S/2$				V			
I _{OUT} Output Current ±30 mA			$R_L = 200\Omega$ to $V_S / 2$				V			
	I _{OUT}	Output Current			±30		mA			

Electrical Characteristics at +5V

 T_A = 25°C, V_S = +5V, R_f = R_g = 5k Ω , R_L = 10k Ω to V_S /2; G = 2; unless otherwise noted.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
Frequency	Domain Response					
$UGBW_{SS}$	Unity Gain -3dB Bandwidth	$G = +1, V_{OUT} = 0.02V_{pp}$		4.3		MHz
BW_{SS}	-3dB Bandwidth	$G = +2, V_{OUT} = 0.2V_{pp}$		3.0		MHz
BW _{LS}	Large Signal Bandwidth	$G = +2$, $V_{OUT} = 2V_{pp}$		2.3		MHz
GBWP	Gain Bandwidth Product	$G = +11, V_{OUT} = 0.2V_{pp}$		2.5		MHz
Time Doma	in Response					
t _R , t _F	Rise and Fall Time	V _{OUT} = 1V step; (10% to 90%)		110		ns
t _S	Settling Time to 0.1%	V _{OUT} = 2V step		470		ns
OS	Overshoot	V _{OUT} = 1V step		<1		%
SR	Slew Rate	2V step		9		V/µs
Distortion/N	loise Response	*10, "10	1			'
HD2	2nd Harmonic Distortion	10kHz, V _{OUT} = 1V _{pp}		-73		dBc
HD3	3rd Harmonic Distortion	10kHz, V _{OUT} = 1V _{pp}		-75		dBc
THD	Total Harmonic Distortion	10kHz, V _{OUT} = 1V _{pp}		0.03		%
e _n	Input Voltage Noise	>10kHz		22		nV/√Hz
		Channel to Channel, Vout = 2Vpp, f = 10kHz		82		dB
X_{TALK}	Crosstalk	Channel to Channel, V _{OUT} = 2V _{pp} , f = 50kHz		74		dB
DC Perform	nance	The install				
V _{IO}	Input Offset Voltage	0,00,00	-8	1.5	8	mV
d _{VIO}	Average Drift	(2,100		15		μV/°C
I _B	Input Bias Current	111 101 10		90	450	nA
dl_B	Average Drift	0,000		40		pA/°C
PSRR	Power Supply Rejection Ratio	DC O	55	85		dB
A _{OL}	Open Loop Gain	Vour = Vs / 2		80		dB
Is	Supply Current	per channe		160	235	μΑ
Input Chara	acteristics	10 0				
R _{IN}	Input Resistance	Non-inverting		12		ΜΩ
C _{IN}	Input Capacitance	20		2		pF
CMIR	Common Mode Input Range	3		-0.25 to 5.25		V
CMRR	Common Mode Rejection Ratio	DC	58	80		dB
Output Cha						
	and	$R_L = 10k\Omega$ to $V_S / 2$	0.08 to 4.92	0.04 to 4.96		V
V_{OUT}	Output Voltage Swing	$R_L = 1k\Omega$ to $V_S/2$		0.07 to 4.9		V
		$R_L = 200\Omega$ to $V_S / 2$		0.14 to 4.67		V
I _{OUT}	Output Current			±35		mA

CLC2011 Pin Configurations SOIC-8 / MSOP-8

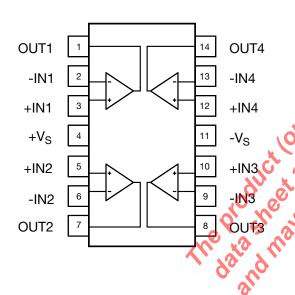


CLC2011 Pin Assignments

SOIC-8 / MSOP-8

Pin No.	Pin Name	Description	
1	OUT1	Output, channel 1	
2	-IN1	Negative input, channel 1	
3	+IN1	Positive input, channel 1	
4	-V _S	Negative supply	
5	+IN2	Positive input, channel 2	
6	-IN2	Negative input, channel 2	
7	OUT2	Output, channel 2	
8	+V _S	Positive supply	

CLC4011 Pin Configuration SOIC-14 / TSSOP-14



CLC4011 Pin Assignments

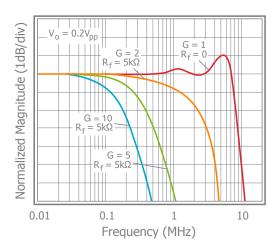
SOIC-14 / TSSOP-14

Pin No.	Pin Name	Description				
1	OUT1	Output, channel 1				
2	JN1	Negative input, channel 1				
3	+IN1	Positive input, channel 1				
N A C	+V _S	Positive supply				
5 0	+IN2	Positive input, channel 2				
60	-IN2	Negative input, channel 2				
7	OUT2	Output, channel 2				
8	OUT3	Output, channel 3				
9	-IN3	Negative input, channel 3				
10	+IN3	Positive input, channel 3				
11	-V _S	Negative supply				
12	+IN4	Positive input, channel 4				
13	-IN4	Negative input, channel 4				
14	OUT4	Output, channel 4				

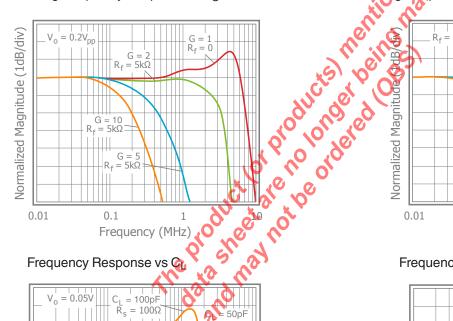
Typical Performance Characteristics

 T_A = 25°C, V_S = +2.7V, R_f = R_g = 5k Ω , R_L = 10k Ω to V_S /2; G = 2; unless otherwise noted.

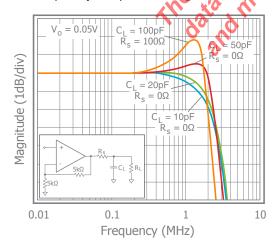
Non-Inverting Frequency Response at $V_S = 5V$



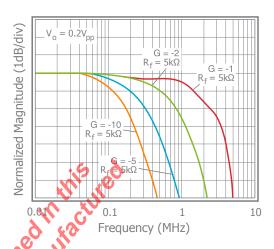
Non-Inverting Frequency Response at $V_S = 2.7V$

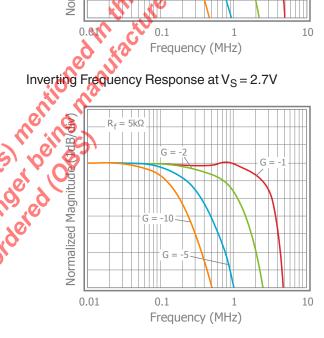


Frequency Response vs 🚱

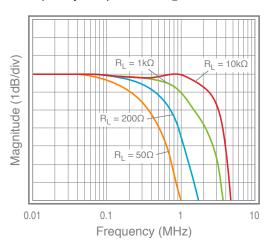


Inverting Frequency Response at $V_S = 5V$





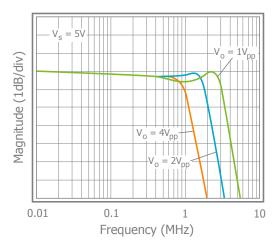
Frequency Response vs RL



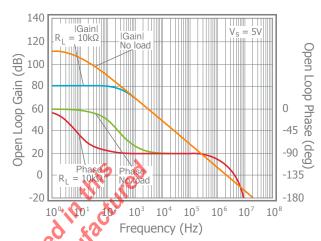
Typical Performance Characteristics

 T_A = 25°C, V_S = +2.7V, R_f = R_g = 5k Ω , R_L = 10k Ω to V_S /2; G = 2; unless otherwise noted.

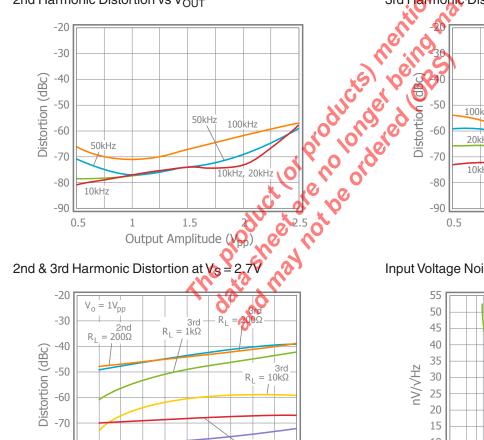
Frequency Response vs. VOUT

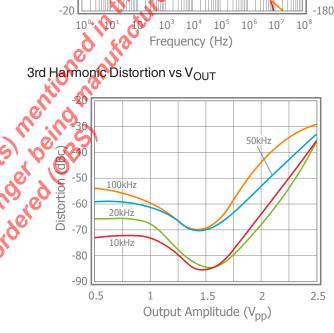


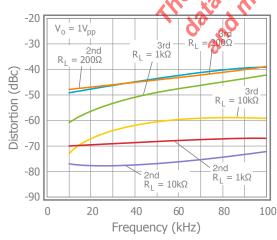
Open Loop Gain & Phase vs. Frequency



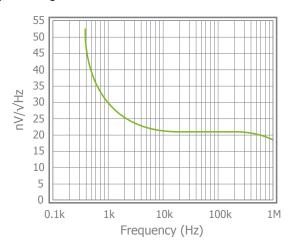
2nd Harmonic Distortion vs V_{OUT}







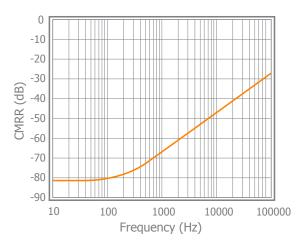
Input Voltage Noise



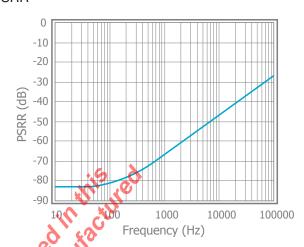
Typical Performance Characteristics

 T_A = 25°C, V_S = +2.7V, R_f = R_g = 5k Ω , R_L = 10k Ω to V_S /2; G = 2; unless otherwise noted.

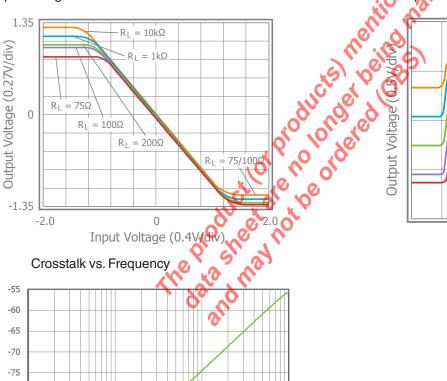
CMRR

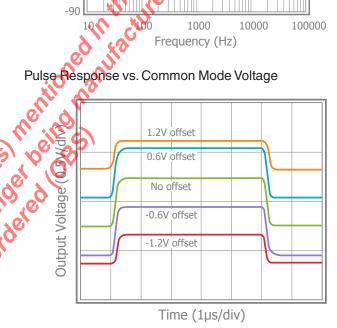


PSRR

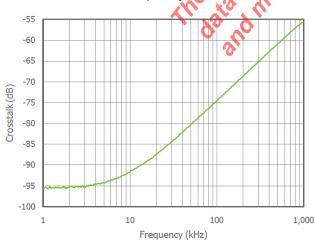


Output Swing vs. Load





Crosstalk vs. Frequency



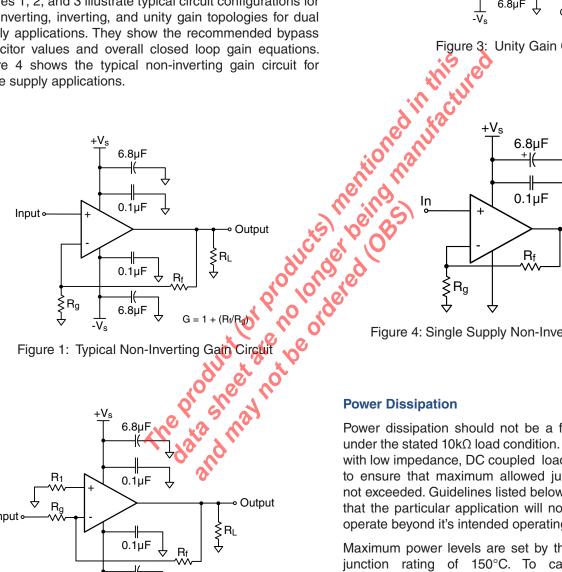
Application Information

General Description

The CLCx011 family of amplifiers are single supply, general purpose, voltage-feedback amplifiers. They are fabricated on a complimentary bipolar process, feature a rail-to-rail input and output, and are unity gain stable.

Basic Operation

Figures 1, 2, and 3 illustrate typical circuit configurations for non-inverting, inverting, and unity gain topologies for dual supply applications. They show the recommended bypass capacitor values and overall closed loop gain equations. Figure 4 shows the typical non-inverting gain circuit for single supply applications.



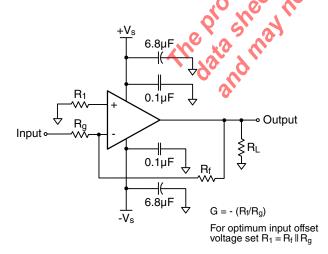


Figure 2: Typical Inverting Gain Circuit

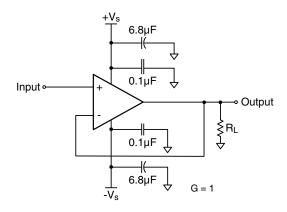


Figure 3: Unity Gain Circuit

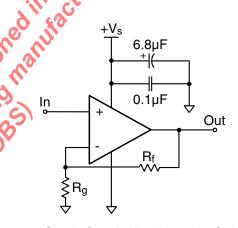


Figure 4: Single Supply Non-Inverting Gain Circuit

Power dissipation should not be a factor when operating under the stated $10k\Omega$ load condition. However, applications with low impedance, DC coupled loads should be analyzed to ensure that maximum allowed junction temperature is not exceeded. Guidelines listed below can be used to verify that the particular application will not cause the device to operate beyond it's intended operating range.

Maximum power levels are set by the absolute maximum junction rating of 150°C. To calculate the junction temperature, the package thermal resistance value Theta, IA (θ_{AA}) is used along with the total die power dissipation.

$$T_{Junction} = T_{Ambient} + (\theta_{JA} \times P_D)$$

Where T_{Ambient} is the temperature of the working environment.

In order to determine P_D , the power dissipated in the load needs to be subtracted from the total power delivered by the supplies.

$$P_D = P_{supply} - P_{load}$$

Supply power is calculated by the standard power equation.

$$P_{supply} = V_{supply} \times I_{RMSsupply}$$

$$V_{supply} = V_{S+} - V_{S-}$$

Power delivered to a purely resistive load is:

$$P_{load} = ((V_{load})_{RMS^2})/Rload_{eff}$$

The effective load resistor (Rload $_{\rm eff}$) will need to include the effect of the feedback network. For instance, Rload $_{\rm eff}$ in Figure 3 would be calculated as:

$$R_L \parallel (R_f + R_g)$$

These measurements are basic and are relatively easy to perform with standard lab equipment. For design purposes however, prior knowledge of actual signal levels and load impedance is needed to determine the dissipated power. Here, P_D can be found from

$$P_D = P_{Quiescent} + P_{Dynamic} - P_{load}$$

Quiescent power can be derived from the specified to values along with known supply voltage, V_{supply}. Load power can be calculated as above with the desired signal amplitudes using:

$$(V_{load})_{RMS} = V_{peak} / J^2$$

($I_{load})_{RMS} = (V_{load})_{RMS} / Rload_{eff}$

The dynamic power is focused primarily within the output stage driving the load. This value can be calculated as:

$$P_{Dynamic} = (V_{S+} - V_{load})_{RMS} \times (I_{load})_{RMS}$$

Assuming the load is referenced in the middle of the power rails or $V_{\text{supply}}/2$.

The CLC2011 is short circuit protected. However, this may not guarantee that the maximum junction temperature (+150°C) is not exceeded under all conditions. Figure 5 shows the maximum safe power dissipation in the package vs. the ambient temperature for the packages available.

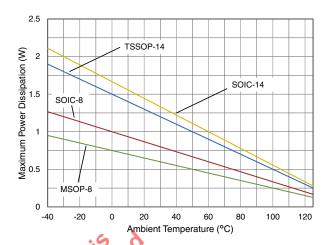


Figure 5. Maximum Power Derating

Input Common Mode Voltage

The common mode input range extends to 250mV below ground and to 250mV above Vs, in single supply operation. Exceeding these values will not cause phase reversal. However, if the input voltage exceeds the rails by more than 0.5V, the input ESD devices will begin to conduct. The output will stay at the rail during this overdrive condition. If the absolute maximum input voltage (700mV beyond either rail) is exceeded, externally limit the input current to ±5mA as shown in Figure 6.

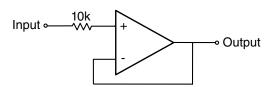


Figure 6. Circuit for Input Current Protection

Driving Capacitive Loads

Increased phase delay at the output due to capacitive loading can cause ringing, peaking in the frequency response, and possible unstable behavior. Use a series resistance, R_S , between the amplifier and the load to help improve stability and settling performance. Refer to Figure 7.

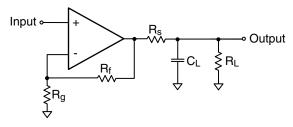


Figure 7. Addition of R_S for Driving Capacitive Loads

Table 1 provides the recommended $R_{\rm S}$ for various capacitive loads. The recommended $R_{\rm S}$ values result in approximately <1dB peaking in the frequency response. The Frequency Response vs. CL plot, on page 6, illustrates the response of the CLCx011.

C _L (pF)	R _S (Ω)	-3dB BW (MHz)
10pF	0	2.2
20pF	0	2.4
50pF	0	2.5
100pF	100	2

Table 1: Recommended R_S vs. C_L

For a given load capacitance, adjust R_S to optimize the tradeoff between settling time and bandwidth. In general, reducing R_S will increase bandwidth at the expense of additional overshoot and ringing.

Overdrive Recovery

An overdrive condition is defined as the point when either one of the inputs or the output exceed their specified voltage range. Overdrive recovery is the time needed for the amplifier to return to its normal or linear operating point. The recovery time varies, based on whether the input or output is overdriven and by how much the range is exceeded. The CLCx011 will typically recover in less than 50ns from an overdrive condition. Figure 8 shows the CLC2011 in an overdriven condition.

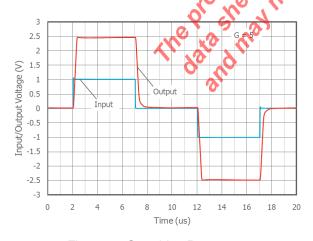


Figure 8: Overdrive Recovery

Layout Considerations

General layout and supply bypassing play major roles in high frequency performance. Exar has evaluation boards to use as a guide for high frequency layout and as an aid in device testing and characterization. Follow the steps below as a basis for high frequency layout:

- Include 6.8µF and 0.1µF ceramic capacitors for power supply decoupling
- Place the 6.8µF capacitor within 0.75 inches of the power pin
- Place the 0.1µF capacitor within 0.1 inches of the power pin
- Remove the ground plane under and around the part, especially near the input and output pins to reduce parasitic capacitance
- Minimize all trace lengths to reduce series inductances

Refer to the evaluation board layouts below for more information.

Evaluation Board Information

The following evaluation boards are available to aid in the testing and layout of these devices:

Evaluation Board #	Products
CEB006	CLC2011 in SOIC
CEB010	CLC2011 in MSOP
CEB019	CLC4011 in TSSOP
CEB018	CLC4011 in SOIC

Evaluation Board Schematics

Evaluation board schematics and layouts are shown in Figures 9-16 These evaluation boards are built for dual-supply operation. Follow these steps to use the board in a single-supply application:

- 1. Short -V_S to ground.
- Use C3 and C4, if the -V_S pin of the amplifier is not directly connected to the ground plane.

exar.com/CLC2011

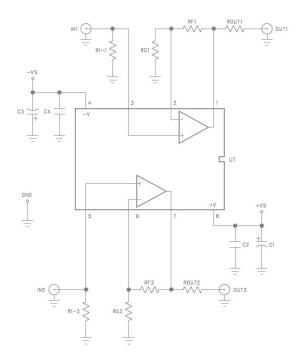


Figure 9. CEB006 & CEB010 Schematic

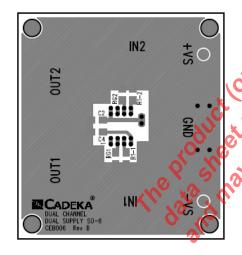


Figure 10. CEB006 Top View

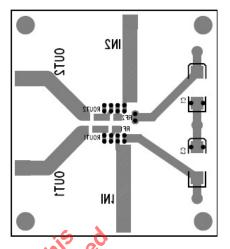


Figure 11. CEB006 Bottom View

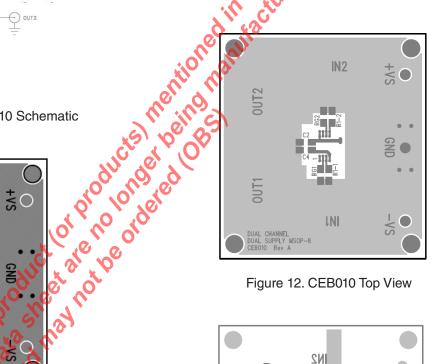


Figure 12. CEB010 Top View

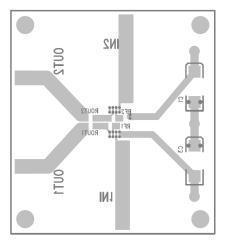


Figure 13. CEB010 Bottom View

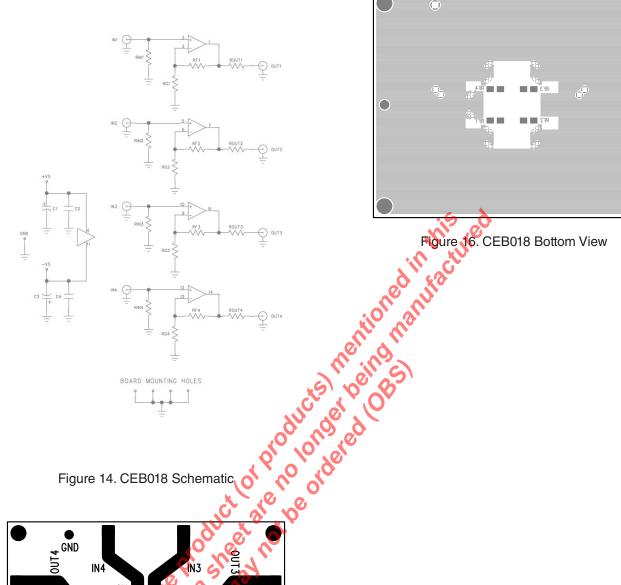


Figure 14. CEB018 Schematic

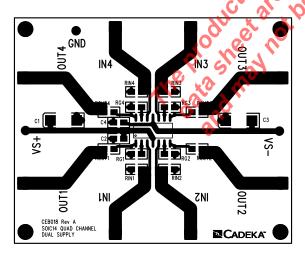
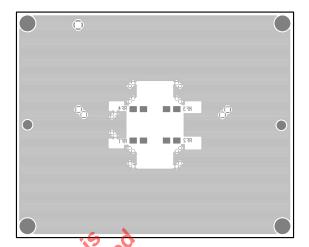
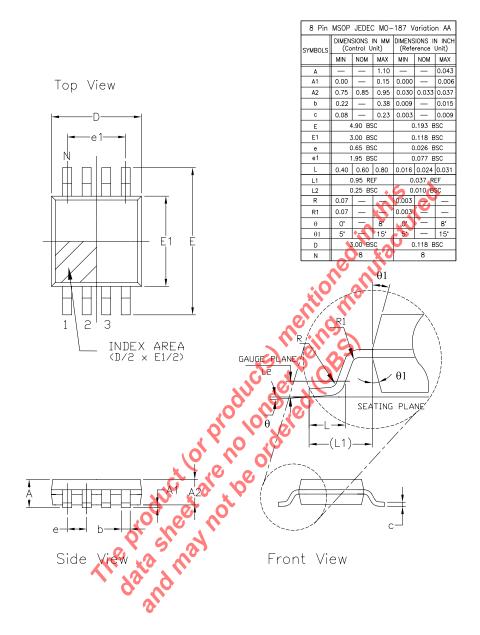


Figure 15. CEB018 Top View

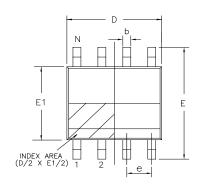


Mechanical Dimensions MSOP-8

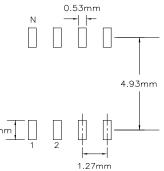


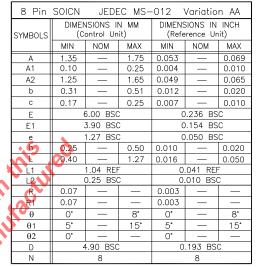
Mechanical Dimensions

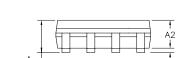
SOIC-8 Package



RECOMMENDED PCB LAND PATTERN

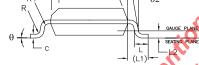






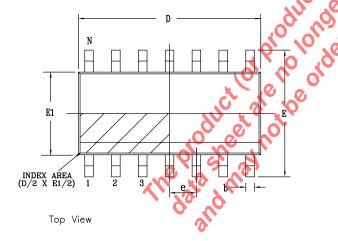
Side View

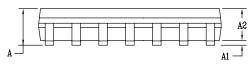
Top View



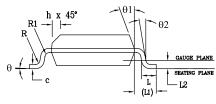
Front View

SOIC-14 Package





Side View

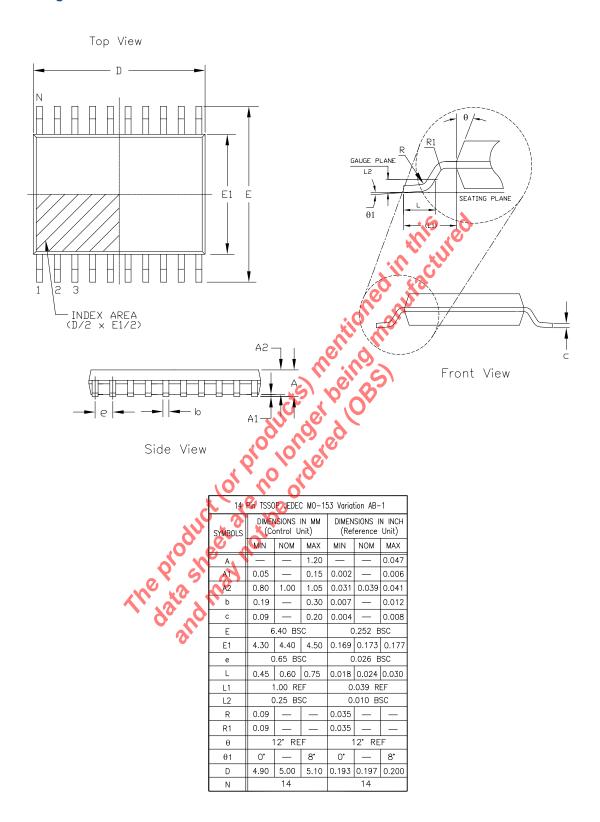


Front View

PACKAGE OUTLINE NSOIC .150" BODY JEDEC MS-012							
SYMBOLS	COMMON DIMENSIONS IN MM COMMON DIMENSIONS IN IN (Reference Unit)						
	MIN	NOM	MAX	MIN	NOM	MAX	
Α	1.35		1.75	0.053	_	0.069	
A1	0.10	_	0.25	0.004	_	0.010	
A2	1.25		1.65	0.049	_	0.065	
ь	0.31		0.51	0.012	_	0.020	
С	0.17		0.25	0.007	_	0.010	
E		3.00 BSC		- 0	.236 BS	С	
E1		3.90 BSC	;		0.154 BS	С	
e		1.27 BSC	;	0.050 BSC			
h	0.25	_	0.50	0.010	_	0.020	
L	0.40	_	1.27	0.016	-	0.050	
L1		1.04 REF	7	0	.041 REI		
L2		0.25 BSC		0	.010 BS		
R	0.07	_	_	0.003	_	_	
R1	0.07	_	_	0.003	_	_	
θ	0,	_	8.	0,	_	8,	
θ1	5*		15°	5*	_	15°	
θ2	0, — — 0, —						
D	D SEE VARIATIONS						
N	N SEE VARIATIONS						

	VARIATION D							
	VARIATIONS		DIMENSIONS IN MM (Control Unit)		DIMENSIONS IN INCH (Reference Unit)			N
l	SNO	MIN	NOM	MAX	MIN	NOM	MAX	
ı	AA	4	.90 BS	С	0	.193 BS	SC .	8
	AB	8	.65 BS	С	0	.341 BS	SC	14
[AC	9	.90 BS	С	0	.390 BS	SC .	16

TSSOP-14 Package



Ordering Information

Part Number	Package	Green	Operating Temperature Range	Packaging	
CLC2011 Ordering Information					
CLC2011ISO8X	SOIC-8 Yes -40°C to +125°C		-40°C to +125°C	Tape & Reel	
CLC2011ISO8MTR	SOIC-8	Yes	-40°C to +125°C	Mini Tape & Reel	
CLC2011ISO8EVB	Evaluation Board	N/A	N/A	N/A	
CLC2011IMP8X	MSOP-8	Yes	-40°C to +125°C	Tape & Reel	
CLC2011IMP8MTR	MSOP-8	Yes	-40°C to +125°C	Mini Tape & Reel	
CLC2011IMP8EVB	Evaluation Board	N/A	N/A	N/A	
CLC4011 Ordering Information					
CLC4011ISO14X	SOIC-14	Yes	-40°C to +125°C	Tape & Reel	
CLC4011ISO14MTR	SOIC-14	Yes	-40°C to +125°C	Mini Tape & Reel	
CLC4011ISO14EVB	Evaluation Board	N/A	N/A	N/A	
CLC4011ITP14X	TSSOP-14	Yes	-40°C to +125°C	Tape & Reel	
CLC4011ITP14MTR	TSSOP-14	Yes	-40°C to +125°C	Mini Tape & Reel	
CLC4011ITP14EVB	4EVB Evaluation Board		N/A	N/A	

Moisture sensitivity level for all parts is MSL-1. Mini tape and reel quantity is 250.

Revision History

	Revision	Date	Description				
	1D (ECN 1504-01)	January 19, 2015 Beformat into Exar data sheet template. Updated PODs and thermal resistance numbers. Updated ordering information table to include MTR and EVB part numbers. Increased operating temperature to +125°C.					
	the product are not be of						
For Further Assistance:							
Email: CustomerSupport@exar.com or HPATechSupport@exar.com							
Ex	Exar Technical Documentation: http://www.exar.com/techdoc/						

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